# Functional Safety Information

# ADS7951-Q1

# Functional Safety FIT Rate, FMD and Pin FMA



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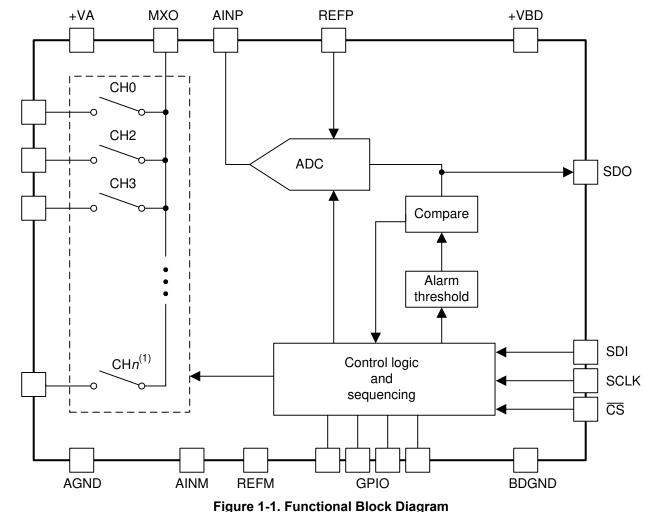


#### 1 Overview

This document contains information for ADS7951-Q1 (TSSOP package) to aid in a functional safety system design. Information provided are:

- Functional Safety Failure In Time (FIT) rates of the semiconductor component estimated by the application of industry reliability standards
- · Component failure modes and their distribution (FMD) based on the primary function of the device
- Pin failure mode analysis (Pin FMA)

Figure 1-1 shows the device functional block diagram for reference.



ADS7951-Q1 was developed using a quality-managed development process, but was not developed in accordance with the IEC 61508 or ISO 26262 standards.



# 2 Functional Safety Failure In Time (FIT) Rates

This section provides Functional Safety Failure In Time (FIT) rates for ADS7951-Q1 based on two different industry-wide used reliability standards:

- Table 2-1 provides FIT rates based on IEC TR 62380 / ISO 26262 part 11
- Table 2-2 provides FIT rates based on the Siemens Norm SN 29500-2

Table 2-1. Component Failure Rates per IEC TR 62380 / ISO 26262 Part 11

| FIT IEC TR 62380 / ISO 26262 | FIT (Failures Per 10 <sup>9</sup> Hours) |
|------------------------------|--|
| Total Component FIT Rate     | 16                                       |
| Die FIT Rate                 | 2  |
| Package FIT Rate             | 14                                       |

The failure rate and mission profile information in Table 2-1 comes from the Reliability data handbook IEC TR 62380 / ISO 26262 part 11:

Mission Profile: Motor Control from Table 11

Power dissipation: 21 mW

Climate type: World-wide Table 8Package factor (lambda 3): Table 17b

Substrate Material: FR4

· EOS FIT rate assumed: 0 FIT

Table 2-2. Component Failure Rates per Siemens Norm SN 29500-2

| Table | Category                                | Reference FIT Rate | Reference Virtual T <sub>J</sub> |
|-------|---|--------------------|----------------------------------|
| 5     | CMOS, BICMOS<br>Digital, analog / mixed | 25 FIT             | 55°C                             |

The Reference FIT Rate and Reference Virtual T<sub>J</sub> (junction temperature) in Table 2-2 come from the Siemens Norm SN 29500-2 tables 1 through 5. Failure rates under operating conditions are calculated from the reference failure rate and virtual junction temperature using conversion information in SN 29500-2 section 4.



# 3 Failure Mode Distribution (FMD)

The failure mode distribution estimation for ADS7951-Q1 in Table 3-1 comes from the combination of common failure modes listed in standards such as IEC 61508 and ISO 26262, the ratio of sub-circuit function size and complexity and from best engineering judgment.

The failure modes listed in this section reflect random failure events and do not include failures due to misuse or overstress.

Table 3-1. Die Failure Modes and Distribution

| Die Failure Modes               | Failure Mode Distribution (%) |
|---------------------------------|-------------------------------|
| Incorrect channel selected      | 15%                           |
| Channel-channel short           | 15%                           |
| ADC output code bit error       | 15%                           |
| ADC gain out of specification   | 20%                           |
| ADC offset out of specification | 20%                           |
| Communication error             | 15%                           |



# 4 Pin Failure Mode Analysis (Pin FMA)

This section provides a Failure Mode Analysis (FMA) for the pins of the ADS7951-Q1. The failure modes covered in this document include the typical pin-by-pin failure scenarios:

- Pin short-circuited to Ground (see Table 4-2)
- Pin open-circuited (see Table 4-3)
- Pin short-circuited to an adjacent pin (see Table 4-4)
- Pin short-circuited to supply (see Table 4-5)

Table 4-2 through Table 4-5 also indicate how these pin conditions can affect the device as per the failure effects classification in Table 4-1.

| Table | 1_1    | TI | Classi | fication | of Failure | Effects |
|-------|--------|----|--------|----------|------------|---------|
| Iaune | 4- I . |    | CIASSI | псаноп   | UI Fallule | EHECIS  |

| Class | Failure Effects   |
|-------|---|
| Α     | Potential device damage that affects functionality          |
| В     | No device damage, but loss of functionality                 |
| С     | No device damage, but performance degradation               |
| D     | No device damage, no impact to functionality or performance |

Figure 4-1 shows the ADS7951-Q1 pin diagram. For a detailed description of the device pins please refer to the *Pin Configuration and Functions* section in the ADS7951-Q1 data sheet.

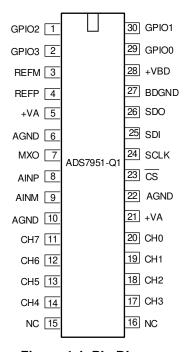


Figure 4-1. Pin Diagram

Following are the assumptions of use and the device configuration assumed for the pin FMA in this section:

- +VA and +VBD use the same supply voltage.
- AGND, REFM and BDGND use the same GND.
- RC filters on every analog input, CHx. Series resistors are sized to limit the input currents into the analog inputs to <10mA in all circumstances, e.g. also in case device is unpowered and input signal is applied.
- · Device is the only slave on the SPI bus.



### Table 4-2. Pin FMA for Device Pins Short-Circuited to Ground

| Pin Name | Pin No. | Description of Potential Failure Effect(s)  | Failure<br>Effect<br>Class |
|----------|---------|---|----------------------------|
| GPIO2    | 1       | GPIO2 configured as digital output: GPIO2 stuck low. Increase in supply current when GPIO2 tries to drive high. Device damage may be plausible.   | Α                          |
|          |         | GPIO2 configured as digital input: GPIO2 stuck low. Readback value of GPIO2 will be 0b.   | В                          |
| GPIO3    | 2       | GPIO3 configured as digital output: GPIO3 stuck low. Increase in supply current when GPIO3 tries to drive high. Device damage may be plausible.   | Α                          |
|          |         | GPIO3 configured as digital input: GPIO3 stuck low. Readback value of GPIO3 will be 0b.   | В                          |
| REFM     | 3       | No effect. Normal operation.  | D                          |
| REFP     | 4       | Reference voltage to the ADC will be 0 V as REFP = REFM = Ground. Incorrect conversion result for all channels. Conversion result for all channels will be close to 0xFFF.  | В                          |
| +VA      | 5       | Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  | Α                          |
| AGND     | 6       | No effect. Normal operation.  | D                          |
| MXO      | 7       | Conversion results for all channels will be close to 0x000. Multiplexer's analog inputs CH7-CH0 will be connected to Ground through MXO. Increase in current sourced from the analog inputs.  | В                          |
|          |         | External amplifier used between MXO and AINP: Conversion results for all channels will be close to 0x000. External amplifier's output will be connected to Ground.  | В                          |
| AINP     | 8       | MXO directly connected to AINP: Conversion results for all channels will be close to 0x000. Multiplexer's analog inputs CH7-CH0 will be connected to Ground through MXO and there will be increase in current sourced from the external circuits driving the analog inputs. | В                          |
| AINM     | 9       | No effect. Normal operation.  | D                          |
| AGND     | 10      | No effect. Normal operation.  | D                          |
| CH7      | 11      | Conversion result for this analog input channel will be close to 0x000.   | В                          |
| CH6      | 12      | Conversion result for this analog input channel will be close to 0x000.   | В                          |
| CH5      | 13      | Conversion result for this analog input channel will be close to 0x000.   | В                          |
| CH4      | 14      | Conversion result for this analog input channel will be close to 0x000.   | В                          |
| NC       | 15      | No effect. Normal operation.  | D                          |
| NC       | 16      | No effect. Normal operation.  | D                          |
| CH3      | 17      | Conversion result for this analog input channel will be close to 0x000.   | В                          |
| CH2      | 18      | Conversion result for this analog input channel will be close to 0x000.   | В                          |
| CH1      | 19      | Conversion result for this analog input channel will be close to 0x000.   | В                          |
| CH0      | 20      | Conversion result for this analog input channel will be close to 0x000.   | В                          |
| +VA      | 21      | Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  | А                          |
| AGND     | 22      | No effect. Normal operation.  | D                          |
| CS       | 23      | CS stuck low. No SPI communication with the device possible.  | В                          |
| SCLK     | 24      | SCLK stuck low. No SPI communication with the device possible.  | В                          |
| SDI      | 25      | SDI stuck low. Device configuration cannot be modified. Device will remain in previously configured state until reset condition occurs. Device will remain in default configuration after power-up.   | В                          |
| SDO      | 26      | SDO stuck low. No data readback possible from the device. Increase in supply current when device tries to drive SDO high. Device damage may be plausible.   | Α                          |
| BDGND    | 27      | No effect. Normal operation.  | D                          |
| +VBD     | 28      | Digital interface not powered up. No SPI communication with device possible. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  | А                          |
| GPIO0    | 29      | GPIO0 configured as digital output: GPIO0 stuck low. Increase in supply current when GPIO0 tries to drive high. Device damage may be plausible.   | А                          |
|          |         | GPIO0 configured as digital input: GPIO0 stuck low. Readback value of GPIO0 will be 0b.   | В                          |



# Table 4-2. Pin FMA for Device Pins Short-Circuited to Ground (continued)

| Pin Name | Pin No. | Description of Potential Failure Effect(s)  | Failure<br>Effect<br>Class |
|----------|---------|---|----------------------------|
| GPIO1    |         | GPIO1 configured as digital output: GPIO1 stuck low. Increase in supply current when GPIO1 tries to drive high. Device damage may be plausible. | А                          |
|          |         | GPIO1 configured as digital input: GPIO1 stuck low. Readback value of GPIO1 will be 0b.   | В                          |

#### Table 4-3. Pin FMA for Device Pins Open-Circuited

| Pin Name | Pin No. | Description of Potential Failure Effect(s)   | Failur<br>Effect<br>Class |
|----------|---------|--|---------------------------|
| GPIO2    | 1       | GPIO2 configured as digital output: No logic signaling between GPIO2 and external circuit possible. Otherwise normal operation.  | В                         |
|          |         | GPIO2 configured as digital input: Readback value of GPIO2 will be unknown.  | В                         |
| GPIO3 2  | 2       | GPIO3 configured as digital output: No logic signaling between GPIO3 and external circuit possible. Otherwise normal operation.  | В                         |
|          |         | GPIO3 configured as digital input: Readback value of GPIO3 will be unknown.  | В                         |
| REFM     | 3       | Incorrect conversion result for all channels. The ADC reference will connect to ground internally through REFM pin ESD diode. Increased gain error for all channels due to reference voltage drop across ESD diode.  | В                         |
| REFP     | 4       | Incorrect and unknown conversion result for all channels. Unknown reference voltage to the ADC. The reference circuit may power-up through internal circuit to Power.  | В                         |
| +VA      | 5       | Device functionality unknown. Device unpowered and not functional if all external analog pins are held low. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  Device may power up through internal ESD diodes to +VA if voltages above the device's power-on reset threshold are present on any of the analog pins. | А                         |
| AGND     | 6       | Device functionality unknown. Device may be unpowered or connect to ground internally through alternate pin ESD diode and power up.  | В                         |
| MXO      | 7       | External amplifier used between MXO and AINP: Multiplexer's analog inputs CH7-CH0 cannot be connected to the external amplifier's input. Conversion results for all channels will depend on the output voltage of the amplifier driving AINP.  | В                         |
| WINCE T  |         | MXO directly connected to AINP: Multiplexer's analog inputs CH7-CH0 cannot be connected to the ADC's input. Conversion results for all channels will be unknown.   | В                         |
| AINP     | 8       | Conversion results for all channels will be unknown.   | В                         |
| AINM     | 9       | Conversion results for all channels will be unknown.   | В                         |
| AGND     | 10      | Device functionality unknown. Device may be unpowered or connect to ground internally through alternate pin ESD diode and power up.  | В                         |
| CH7      | 11      | Conversion result for this analog input channel will be unknown.   | В                         |
| CH6      | 12      | Conversion result for this analog input channel will be unknown.   | В                         |
| CH5      | 13      | Conversion result for this analog input channel will be unknown.   | В                         |
| CH4      | 14      | Conversion result for this analog input channel will be unknown.   | В                         |
| NC       | 15      | No effect. Normal operation.   | D                         |
| NC       | 16      | No effect. Normal operation.   | D                         |
| CH3      | 17      | Conversion result for this analog input channel will be unknown.   | В                         |
| CH2      | 18      | Conversion result for this analog input channel will be unknown.   | В                         |
| CH1      | 19      | Conversion result for this analog input channel will be unknown.   | В                         |
| CH0      | 20      | Conversion result for this analog input channel will be unknown.   | В                         |
| +VA      | 21      | Device functionality unknown. Device unpowered and not functional if all external analog pins are held low. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  Device may power up through internal ESD diodes to +VA if voltages above the device's power-on reset threshold are present on any of the analog pins. | Α                         |
| AGND     | 22      | Device functionality unknown. Device may be unpowered or connect to ground internally through alternate pin ESD diode and power up.  | В                         |
| CS       | 23      | State of $\overline{\text{CS}}$ undetermined. No SPI communication with the device possible.   | В                         |



#### Table 4-3. Pin FMA for Device Pins Open-Circuited (continued)

| Pin Name | Pin No. | Description of Potential Failure Effect(s)   | Failure<br>Effect<br>Class |
|----------|---------|--|----------------------------|
| SCLK     | 24      | State of SCLK undetermined. No SPI communication with the device possible.   | В                          |
| SDI      | 25      | State of SDI undetermined. Device configuration cannot be modified. Device will remain in previously configured state until reset condition occurs. Device will remain in default configuration after power-up.  | В                          |
| SDO      | 26      | No data readback possible from the device.   | В                          |
| BDGND    | 27      | Device functionality unknown. Digital interface may be unpowered or power up internally through alternate pin ESD diode to Ground. SPI communication may not be possible with the device.  | В                          |
| +VBD     | 28      | Digital interface not powered up if all external digital pins are held low. No SPI communication with device possible. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  Digital interface may power up through internal ESD diodes to DVDD if voltages above the device's power-on reset threshold are present on any of the digital pins. | А                          |
| GPIO0    | 29      | GPIO0 configured as digital output: No logic signaling between GPIO0 and external circuit possible. Otherwise normal operation.  | В                          |
|          |         | GPIO0 configured as digital input: Readback value of GPIO0 will be unknown.  | В                          |
| GPIO1    | 30      | GPIO1 configured as digital output: No logic signaling between GPIO1 and external circuit possible. Otherwise normal operation.  | В                          |
|          |         | GPIO1 configured as digital input: Readback value of GPIO1 will be unknown.  | В                          |

# Table 4-4. Pin FMA for Device Pins Short-Circuited to Adjacent Pin

| Pin Name | Pin No. | Shorted to | Description of Potential Failure Effect(s)   | Failure<br>Effect<br>Class   |   |   |
|----------|---------|------------|--|--|---|---|
|          |         |            |  | GPIO2 configured as digital output and GPIO3 as digital output: Output voltage level unknown. Increase in supply current when GPIO2 tries to drive low and GPIO3 tries to drive high and vice versa. Device damage may be plausible. | Α   |   |
| GPIO2    | 1       | GPIO3      | GPIO2 configured as digital output and GPIO3 as digital input: Readback value of GPIO3 will depend on the output drive on GPIO2.   | В  |   |   |
|          |         |            | GPIO2 configured as digital input and GPIO3 as digital output: Readback value of GPIO2 will depend on the output drive on GPIO3.   | В  |   |   |
|          |         |            | GPIO2 configured as digital input and GPIO3 as digital input: Readback value of GPIO2 and GPIO3 will be the same.  | В  |   |   |
|          | GPIO3 2 | 0 5        |  | REFM   | GPIO3 configured as digital output: GPIO3 stuck low. Increase in supply current when GPIO3 tries to drive high. Device damage may be plausible. | Α |
| GPIO3    |         | REFIN      | GPIO3 configured as digital input: GPIO3 stuck low. Readback value of GPIO3 will be 0b.  | В  |   |   |
| REFM     | 3       | REFP       | Incorrect conversion result for all channels. Conversion result will be close to 0xFFF for all channels. Reference voltage to the ADC will be 0 V as REFP = REFM = Ground.   | В  |   |   |
| REFP     | 4       | +VA        | Incorrect conversion result for all channels. Higher gain error for all channels because reference to the ADC is different from the intended REFP voltage. Reference voltage out of specification in case +VA > 3 V.   | В  |   |   |
| +VA      | 5       | AGND       | Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.   | A  |   |   |
| AGND     | 6       | MXO        | Conversion results for all channels will be close to 0x000. Multiplexer's analog inputs CH7-CH0 will be connected to Ground through MXO. Increase in current sourced from the analog inputs.   | В  |   |   |
| МХО      | 7       | AINP       | External amplifier used between MXO and AINP: The external amplifier is bypassed. Increased gain error in conversion results if the external amplifier is configured for gain > 1. Conversion results for all channels may have higher error if there are ADC input settling errors when driving AINP directly with MXO. | В  |   |   |
|          |         |            | MXO directly connected to AINP: No effect. Normal operation.   | D  |   |   |
| AINP     | 8       | AINM       | Conversion results for all channels will be close to 0x000.  | В  |   |   |



Table 4-4. Pin FMA for Device Pins Short-Circuited to Adjacent Pin (continued)

|          | able 4-4.     | PIN FIVIA TOT D  | evice Pins Short-Circuited to Adjacent Pin (continued)  | Failure  |   |
|----------|---------------|--|---|--|---|
| Pin Name | Pin No.       | Shorted to   | Description of Potential Failure Effect(s)  | Effect<br>Class  |   |
| AINM     | 9             | AGND   | No effect. Normal operation.  | D  |   |
| AGND     | 10            | CH7  | Conversion result for CH7 will be close to 0x000.   | В  |   |
| CH7      | 11            | CH6  | Conversion results for CH7 and CH6 will be the same. The conversion results may be incorrect depending on the external drive circuits.  | В  |   |
| CH6      | 12            | CH5  | Conversion results for CH6 and CH5 will be the same. The conversion results may be incorrect depending on the external drive circuits.  | В  |   |
| CH5      | 13            | CH4  | Conversion results for CH5 and CH4 will be the same. The conversion results may be incorrect depending on the external drive circuits.  | В  |   |
| CH4      | 14            | NC   | No effect. Normal operation.  | D  |   |
| NC       | 15            | _  | Not considered. Corner pin.   | _  |   |
| NC       | 16            | CH3  | No effect. Normal operation.  | D  |   |
| СНЗ      | 17            | CH2  | Conversion results for CH3 and CH2 will be the same. The conversion results may be incorrect depending on the external drive circuits.  | В  |   |
| CH2      | 18            | CH1  | Conversion results for CH2 and CH1 will be the same. The conversion results may be incorrect depending on the external drive circuits.  | В  |   |
| CH1      | 19            | СН0  | Conversion results for CH1 and CH0 will be the same. The conversion results may be incorrect depending on the external drive circuits.  | В  |   |
| CUO      | 20            |  | Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  | В  |   |
| CH0      | 20            | +VA  | Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  | В  |   |
| +VA      | 21            | AGND   | Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  | А  |   |
| AGND     | 22            | CS   | CS stuck low. No SPI communication with the device possible.  | В  |   |
| CS       | 23            | SCLK   | SPI communication corrupted. No SPI communication with the device possible.   | В  |   |
| SCLK     | 24            | SDI  | SPI communication corrupted. No SPI communication with the device possible.   | В  |   |
| SDI      | 25            | SDO  | SPI communication corrupted. No SPI communication with the device possible.  Increase in supply current when host tries to drive SDI low while device tries to drive SDO high and vice versa. Device damage may be plausible. | A  |   |
| SDO      | 26            | BDGND  | SDO stuck low. No data readback possible from the device. Increase in supply current when device tries to drive SDO high. Device damage may be plausible.   | А  |   |
| BDGND    | 27            | +VBD   | Digital interface not powered up. No SPI communication with device possible. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.                          | А  |   |
| ±\/BD    | 20            | GPIO0  | GPIO0 configured as digital output: GPIO0 stuck high. Increase in supply current when GPIO0 tries to drive low. Device damage may be plausible.   | А  |   |
| +VBD     | 28            | GFIOU  | GPIO0 configured as digital input: GPIO0 stuck high. Readback value of GPIO0 will be 1b.  | В  |   |
|          | GPIO0 29 GPIO |  |   | GPIO0 configured as digital output and GPIO1 as digital output: Increase in supply current when GPIO0 tries to drive low and GPIO1 tries to drive high and vice versa. Device damage may be plausible. | Α |
| GPIO0    |               | GPIO1  | GPIO0 configured as digital output and GPIO1 as digital input: Readback value of GPIO1 will depend on the output drive on GPIO0.  | В  |   |
|          |               | GPIO0 configured as digital input and GPIO1 as digital output: Readback value of GPIO0 will depend on the output drive on GPIO1. |   | В  |   |
|          |               |  | GPIO0 configured as digital input and GPIO1 as digital input: Readback value of GPIO0 and GPIO1 will be the same.   | В  |   |
| GPIO1    | 30            | -  | Not considered. Corner pin.   | D  |   |
|          | -             | -  |   |  |   |



Table 4-5. Pin FMA for Device Pins Short-Circuited to supply

| GPIO2 configured as digital output: GPIO2 stuck high. Increase in supply current when GPIO2 titles to drive low. Device damage may be plausible.  GPIO3 configured as digital input. GPIO2 stuck high. Readback value of GPIO2 will be 1b.  GPIO3 configured as digital output: GPIO3 stuck high. Increase in supply current when GPIO3 titles to drive low. Device damage may be plausible.  GPIO3 configured as digital pout. GPIO3 stuck high. Readback value of GPIO3 will be 1b.  Incorrect conversion result for all channels. The ADC reference will connect to ground internall through REFM pin ESD diode. Increase in supply current whon GPIO3 will be 1b.  Incorrect conversion result for all channels. Higher gain error for all channels due to reference voltage of the ADC is different from the intended REFP voltage. Reference voltage out of specification case +VA > 3 V.  +VA 5 No effect. Normal operation.  AGND 6 the device are met, otherwise device damage may be plausible.  Muto Perice unpowered and not functional. Observe that the absolute maximum ratings for all pins of the ADC is different from the intended REFP voltage. Reference voltage out of specification case +VA > 3 V.  +VA 5 No effect. Normal operation.  MXO 7 Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  Device configured for range 2: Conversion results for all channels will correspond to (+VA / (2x/REF))* 4095.  AIND 8 FM XO is directly connected to AINP, multiplexer's analog inputs CH7-CH0 will be connected to Power through MXO and there will be increase in current sinked by the external circuits driving the analog inputs CH7-CH0 will be connected to Qx/REF).  Device configured for range 2: Conversion results for all channels will correspond to (+VA / (2x/REF))* 4095.  AINM 9 Conversion result for all channels will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will b | 1  | Failui<br>Effec<br>Clas |
|--|----|-------------------------|
| GPIO3 configured as digital output: GPIO3 stuck high. Increase in supply current when GPIO3 tries to drive low. Device damage may be plausible.  GPIO3 configured as digital input: GPIO3 stuck high. Readback value of GPIO3 will be 1b.  Incorrect conversion result for all channels. The ADC reference will connect to ground internally through REFM pin ESD diode. Increase and gain error for all channels due to reference voltage at through REFM pin ESD diode. Increase and gain error for all channels due to reference voltage and through REFM pin ESD diode. Increase and purply current through ESD to Ground from REFM pin. Device damage may be plausible.  REFP  4 Incorrect conversion result for all channels. Higher gain error for all channels because reference to the ADC is different from the intended REFP voltage. Reference voltage out of specification case +VA > 3 V.  4 VA  5 No effect. Normal operation.  AGND  6 Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  MIXO  7 Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  • Device configured for range 2: Conversion results for all channels will be close to 0xFFF.  • Device configured for range 2: Conversion results for all channels will be connected to Power through MXO and there will be increase in current sinked by the external circuits driving the analog inputs.  AINP  8 • Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  • Device configured for range 2: Conversion results for all channels will be close to 0xFFF.  • Device configured for range 2: Conversion results for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  Device configured for range 2: Convers |    | Α                       |
| The sto drive low. Device damage may be plausible.  GPIO3 configured as digital input: GPIO3 stuck high. Readback value of GPIO3 will be 1b.  Incorrect conversion result for all channels. The ADC reference will connect to ground internally through REFM pin ESD diode. Increased gain error for all channels due to reference voltage di admage may be plausible.  Incorrect conversion result for all channels. Higher gain error for all channels because reference to the ADC is different from the intended REFP voltage. Reference voltage out of specification case +VA > 3 V.  +VA 5 No effect. Normal operation.  Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  Multiplexer's analog inputs CH7-CH0 will be connected to Power through MXO. Increase in current sinked by the external circuits driving the analog inputs.  • Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  • Device configured for range 2: Conversion results for all channels will correspond to (+VA / (2x/REF)) * 4095.  AINM 9 Conversion result for all channels will be close to 0xFFF.  • Device configured for range 2: Conversion results for all channels will correspond to (+VA / (2x/REF)) * 4095.  AINM 9 Conversion result for all channels will be close to 0xFFF.  • Device configured for range 2: Conversion results for all channels will be close to 0xFFF.  • Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  |    | В                       |
| Incorrect conversion result for all channels. The ADC reference will connect to ground internally through REFM pin ESD diode. Increase are usually a through REFM pin ESD diode. Increase are usually connected to ground from REFM pin. Device damage may be plausible.  Incorrect conversion result for all channels. Higher gain error for all channels because reference to the ADC is different from the intended REFP voltage. Reference voltage out of specification case +VA > 3 V.  +VA 5 No effect. Normal operation.  AGND 6 Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  Multiplexer's analog inputs CH7-CH0 will be connected to Power through MXO. Increase in current sinked by the external circuits driving the analog inputs.  **NXO 7 Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  **Device configured for range 2: Conversion results for all channels will be connected to Power through MXO and there will be increase in current sinked by the external circuits driving the analog inputs.  AINP 8 If MXO is directly connected to AINP, multiplexer's analog inputs CH7-CH0 will be connected to Power through MXO and there will be increase in current sinked by the external circuits driving the analog input by the external circuits driving the analog inputs.  **Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  **Device configured for range 2: Conversion results for all channels will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Con |    | Α                       |
| REFM   3   attrough REFM pin ESD diode. Increased gain error for all channels due to reference voltage di across ESD flode. Increase in supply current through ESD to Ground from REFM pin. Device damage may be plausible.   Incorrect conversion result for all channels. Higher gain error for all channels because reference to the ADC is different from the intended REFP voltage. Reference voltage out of specification case +VA 3 3 V.     +VA   5   No effect. Normal operation.   |    | В                       |
| REFP 4 to the ADC is different from the intended REFP voltage. Reference voltage out of specification case +VA > 3 V.  +VA 5 No effect. Normal operation.  AGND 6 Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  Multiplexer's analog inputs CH7-CH0 will be connected to Power through MXO. Increase in current sinked by the external circuits driving the analog inputs.  MXO 7 Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  Device configured for range 2: Conversion results for all channels will correspond to (+VA / (2xVREF))* 4095.  AINP 8 Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  Device configured for range 2: Conversion results for all channels will be close to 0xFFF.  Device configured for range 2: Conversion results for all channels will correspond to (+VA / (2xVREF))* 4095.  AINM 9 Conversion result for all channels will be close to 0x000.  AGND 10 Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF))* 4095.  CH6 12  CH6 12  CH7 13  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for th |    | Α                       |
| AGND 6 Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  Multiplexer's analog inputs CH7-CH0 will be connected to Power through MXO. Increase in current sinked by the external circuits driving the analog inputs.  **Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  **Device configured for range 2: Conversion results for all channels will correspond to (+VA / (2xVREF))* 4095.  AINP  **AINP**  **B**  **If MXO is directly connected to AINP, multiplexer's analog inputs CH7-CH0 will be connected to Power through MXO and there will be increase in current sinked by the external circuits driving the analog inputs.  **AINP**  **B**  **Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  **Device configured for range 2: Conversion results for all channels will be close to 0xFFF.  **Device configured for and to functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  **Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  **Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF))* 4095.  **Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  **Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF))* 4095.  **Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  **Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF))* 4095.  **Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  **Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  **Device |    | В                       |
| Multiplexer's analog inputs CH7-CH0 will be connected to Power through MXO. Increase in current sinked by the external circuits driving the analog inputs.  MXO 7 Device configured for range 1: Conversion results for all channels will be close to 0xFFF. Device configured for range 2: Conversion results for all channels will correspond to (+VA / (2xVREF))* 4095.  AINP 8 Device configured for less in current sinked by the external circuits driving the analog inputs.  AINP 8 Device configured for range 1: Conversion results for all channels will be close to 0xFFF. Device configured for range 1: Conversion results for all channels will be close to 0xFFF. Device configured for range 2: Conversion results for all channels will correspond to (+VA / (2xVREF))* 4095.  AINM 9 Conversion result for all channels will be close to 0x000.  AGND 10 Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  CH7 11 Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF. Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF. Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF. Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF. Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF. Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF. Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF. Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF. Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF. Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF. Device  |    | D                       |
| Current sinked by the external circuits driving the analog inputs.  Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  Device configured for range 2: Conversion results for all channels will correspond to (+VA / (2xVREF)) * 4095.  If MXO is directly connected to AINP, multiplexer's analog inputs CH7-CH0 will be connected to Power through MXO and there will be increase in current sinked by the external circuits driving the analog inputs.  Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  Device configured for range 2: Conversion results for all channels will correspond to (+VA / (2xVREF)) * 4095.  AINM  Genvice unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  CH6  The device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 1: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  CH6  The device configured for range 1: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  CH7  The device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 1: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  CH8  The device configured for range 1: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  CH8  The device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device co | of | Α                       |
| AINP  8 Power through MXO and there will be increase in current sinked by the external circuits driving the analog inputs.  • Device configured for range 1: Conversion results for all channels will be close to 0xFFF.  • Device configured for range 2: Conversion results for all channels will correspond to (+VA / (2xVREF)) * 4095.  AINM  9 Conversion result for all channels will be close to 0x000.  Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to 0xFFF.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to 0xFFF.  Device configu | ,  | В                       |
| AGND 10 Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  CH5  The province configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  CH6  The province configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  NC  The province configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  NC  NC  The province configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  NC  NC  NO effect. Normal operation.   |    | В                       |
| the device are met, otherwise device damage may be plausible.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  CH4  14  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  NC  NC  NO effect. Normal operation.   |    | В                       |
| CH7  11  OXFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  CH5  13  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  CH4  14  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  NC  15  No effect. Normal operation.  | of | Α                       |
| CH6  12  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  CH4  14  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  NC  15  No effect. Normal operation.   | 0  | В                       |
| CH6  12  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  CH4  14  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  NC  15  No effect. Normal operation.   | +  |                         |
| CH5  13  OxFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  NC 15 No effect. Normal operation.  | 0  | В                       |
| Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.  NO 15 No effect. Normal operation.   |    | В                       |
| CH4  14  OxFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond t (+VA / (2xVREF)) * 4095.  NC  15  No effect. Normal operation.   | 0  |                         |
| Device configured for range 2: Conversion result for this analog input channel will correspond t (+VA / (2xVREF)) * 4095.  NC 15 No effect. Normal operation.  |    | В                       |
| · · · · · · · · · · · · · · · · · · ·  | 0  |                         |
|  |    | D                       |
| NC 16 No effect. Normal operation.   |    | D                       |
| CH3  Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.  Device configured for range 2: Conversion result for this analog input channel will correspond to 17  |    | В                       |



Table 4-5. Pin FMA for Device Pins Short-Circuited to supply (continued)

| Pin Name | Pin No. | Description of Potential Failure Effect(s)   | Failure<br>Effect<br>Class   |
|----------|---------|--|--|
| CH2      | 18      | Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.   | - В  |
|          |         | Device configured for range (+VA / (2xVREF)) * 4095.   | Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095. |
| CH1      | 19      | Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.   | - В  |
|          |         | Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.   | - В  |
| СН0      | 20      | Device configured for range 1: Conversion result for this analog input channel will be close to 0xFFF.   | В  |
|          |         | Device configured for range 2: Conversion result for this analog input channel will correspond to (+VA / (2xVREF)) * 4095.   | В  |
| +VA      | 21      | No effect. Normal operation.   | D  |
| AGND     | 22      | Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.   | А  |
| CS       | 23      | CS stuck high. No SPI communication with the device possible. SDO will be Hi-Z.  | В  |
| SCLK     | 24      | SCLK stuck high. No SPI communication with the device possible.  | В  |
| SDI      | 25      | SDI stuck high. Device configuration cannot be modified. Device will remain in previously configured state until reset condition occurs. Device will remain in default configuration after power-up. | В  |
| SDO      | 26      | SDO stuck high. No data readback possible from the device. Increase in supply current when device tries to drive SDO low. Device damage may be plausible.  | А  |
| BDGND    | 27      | Device unpowered and not functional. Observe that the absolute maximum ratings for all pins of the device are met, otherwise device damage may be plausible.   | А  |
| +VBD     | 28      | No effect. Normal operation.   | D  |
| GPIO0    | 29      | GPIO0 configured as digital output: GPIO0 stuck high. Increase in supply current when GPIO2 tries to drive low. Device damage may be plausible.  | А  |
|          |         | GPIO0 configured as digital input: GPIO0 stuck high. Readback value of GPIO0 will be 1b.   | В  |
| GPIO1    | 30      | GPIO1 configured as digital output: GPIO1 stuck high. Increase in supply current when GPIO1 tries to drive low. Device damage may be plausible.  | А  |
|          |         | GPIO1 configured as digital input: GPIO1 stuck high. Readback value of GPIO1 will be 1b.   | В  |

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